

IN THE CLAIMS:

This listing of claims will replace all prior versions and listings of claims in the application:

Listing of Claims:

1 – 12 cancelled.

13. (Currently Amended) The device of claim ~~42~~18, 19, or 29, wherein said application block, said measurement block, said power management block and said processing unit are fabricated on a single die.

14 -17 cancelled.

18. (Currently Amended) ~~The device of claim 17,~~A device comprising:

an application block implementing a user application;

a power management block providing a supply voltage to said application block;

a measurement block measuring a characteristic comprising a propagation delay of a corresponding signal at a plurality of portions on said application block to generate corresponding measured values, said measurement block comprising:

plurality of gated ring oscillators (GROs), wherein each of said plurality of GROs is located at a corresponding one of said plurality of portions, said plurality of GROs generating a corresponding number of signals;

a monitor block generating said measured values representing a propagation delay at said plurality of portions, wherein said processing unit determines a strength of process corner of said application block based on said measured values, and said power management block adjusts said supply voltage to an optimum value based on said strength, said monitor block comprising:

a multiplexer to select one of said signals;

a transition detector generating pulses representing transitions in an output generated by said multiplexor;

a counter receiving a clock signal and counting a number of clock periods of said clock signal between two successive transitions generated by said transition detector to generate a measured value corresponding to said output, wherein said measured value is comprised in said plurality of measured values; and

a capture register storing said measured value; and

a processing unit interfacing with said power management block to adjust said supply voltage to an optimum value based on said measured values.

19. (Currently Amended) ~~The device of claim 17,~~ A device comprising:

an application block implementing a user application;

a power management block providing a supply voltage to said application block;

a measurement block measuring a characteristic comprising a propagation delay of a corresponding signal at a plurality of portions on said application block to generate corresponding measured values, said measurement block comprising:

plurality of gated ring oscillators (GROs), wherein each of said plurality of GROs is located at a corresponding one of said plurality of portions, said plurality of GROs generating a corresponding number of signals;

a monitor block generating said measured values representing said propagation delay at said plurality of portions, wherein said processing unit determines a strength of process corner of said application block based on said measured values, and said power management block adjusts said supply voltage to an optimum value based on said strength, said monitor block comprising:

a multiplexer to select one of said signals; and

a counter generating a measured value by counting number of cycles in an output generated by said multiplexer during a fixed time period, wherein said measured value is comprised in said plurality of measured values.

20. (Currently Amended) The device of claim ~~47~~18, 19 or 29, wherein a high value of said measured values indicates a weak process corner at a corresponding portion, and a low value of said measured values indicates a strong process corner at a corresponding portion.

21. (Original) The device of claim 20, wherein said processing unit is operable to:

select a maximum value and a minimum value from said measured values; and

determine whether to increase or decrease said supply voltage based on said maximum value, wherein said power management block increases said supply voltage if said maximum value has said high value and decreases said supply voltage if said maximum value has said low value.

22. (Original) The device of claim 21, wherein said processing unit is further operable to:

check whether a ratio of said maximum value and said minimum value exceeds a pre-specified threshold; and

use a next highest value instead of said maximum value to perform said determine if said ratio exceeds said pre-specified threshold.

23. (Original) The device of claim 21, wherein said processing unit is further operable to:

receive a first value, a second value and a third value corresponding to a weak process corner, a nominal process corner and a strong process corner respectively for a present supply voltage; and

discard said single die as being unusable if said maximum value is more than a first multiplier of said first value or if said maximum value is less than a second multiplier of said third value.

24. (Original) The device of claim 21, wherein said processing unit determines to increase said supply voltage if said maximum value is less than a first multiplier of said first value and if said maximum value is more than a second multiplier of said third value.

25. (Original) The device of claim 21, wherein said processing unit determines to decrease said supply voltage if said maximum value is less than a first multiplier of said third value and if said maximum value is more than a second multiplier of said third value.

26. (Original) The device of claim 25, further comprises a random access memory (RAM) storing a lookup table containing measured values corresponding to a weak process corner, a nominal process corner and a strong process corner for a plurality of pre-determined levels of said supply voltage and said RAM provides said first value, said second value and said third value.

27. (Original) The device of claim 26, wherein said maximum value comprises the largest value among said plurality of measured values and said minimum value comprises the smallest value among said plurality of measured values.

28. (Cancelled)

29. (Currently Amended) ~~The device of claim 28,~~A device comprising:

an application block implementing a user application;

a power management block providing a supply voltage to said application block wherein
said power management block ~~further~~ comprises:

a register programmed to store an adjustment value, wherein said adjustment value causes said power management block to provide said optimum value of said supply voltage while initializing said single die;

a capacitor charging to said optimum value of said supply voltage;

a second multiplexer selecting one of said adjustment value or an output value of said processing unit as a multiplexer output; ~~and-~~

a controller generating pulses based on said multiplexer output, a reference voltage and present value of said supply voltage, wherein said controller further generates a first signal if said output of said second multiplexer changes or while said capacitor is charging to said optimal value, said controller sending a second signal after said capacitor is charged to said optimum value;

a measurement block measuring a characteristic comprising a propagation delay of a corresponding signal at a plurality of portions on said application block to generate corresponding measured values, said measurement block comprising:

a monitor block generating said measured values representing said propagation delay at said plurality of portions, wherein said processing unit determines a strength of process corner of said application block based on said measured values, and said power management block adjusts said supply voltage to an optimum value based on said strength; and

a processing unit interfacing with said power management block to adjust said supply voltage to an optimum value based on said measured values.

30. (Original) The device of claim 29, wherein said power management block further comprises:

a current limiter receiving said first signal and said second signal, and generating a third signal indicating a normal mode or a constant current mode; and

a power stage receiving said third signal and said pulses, and generating high power pulses in said normal mode, and providing current to said capacitor in said constant current mode.

31. (Cancelled).